

**Search Notes****Application/Control No.**

10/670,154

**Examiner**

Mark K. Han

**Applicant(s)/Patent under Reexamination**

TROCKI ET AL.

**Art Unit**

3767

**SEARCHED**

Class	Subclass	Date	Examiner
604	93.01 118	10/1/2006	meh.
	121		
	131		
	151		
	152		
	154		
	181		
	187		
	500		
	507		
	508		
	533		
	534		
	535		
600	431		
	432		
128	898		
	dig. 1		
	dig. 12		

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST text search	10/1/2006	meh.

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner